

<b>Notice of References Cited</b>	Application/Control No. 10/506,620		Applicant(s)/Patent Under Reexamination AWANO ET AL.	
	Examiner Harry D. Wilkins, III		Art Unit 1795	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,818,107 B2	11-2004	Awano et al.	204/252
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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	S					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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